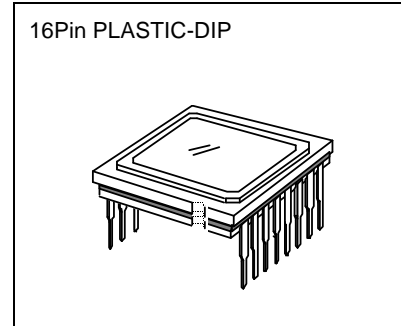


INTRODUCTION

The KC73125MP is an interline transfer CCD area image sensor developed for EIA 1/3 inch video cameras. It can be used for door phones, surveillance cameras, object detection and pattern recognition.



FEATURES

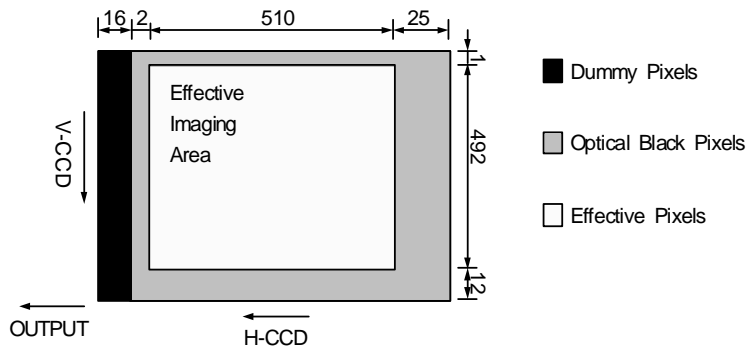
- High Sensitivity
- Optical Size: 1/3 inch Format
- Variable Speed Electronic Shutter (1/60, 1/100 ~ 1/10,000sec)
- Horizontal Register: 5V Drive
- 16pin Plastic DIP Package
- Field Integration Read Out System
- No DC Bias on Reset Gate

ORDERING INFORMATION

Device	Package	Operating
KC73125MP	16Pin PLASTIC-DIP	-10 °C ~ +55 °C

STRUCTURE

- Number of Total Pixels: 537(H) × 505(V)
- Number of Effective Pixels: 510(H) × 492(V)
- Chip Size: 5.90mm(H) × 5.10mm(V)
- Unit Pixel Size: 9.60µm(H) × 7.50µm(V)
- Optical Blacks & Dummies: Refer to Figure Below
Vertical 1 Line (Even Field Only)



BLOCK DIAGRAM

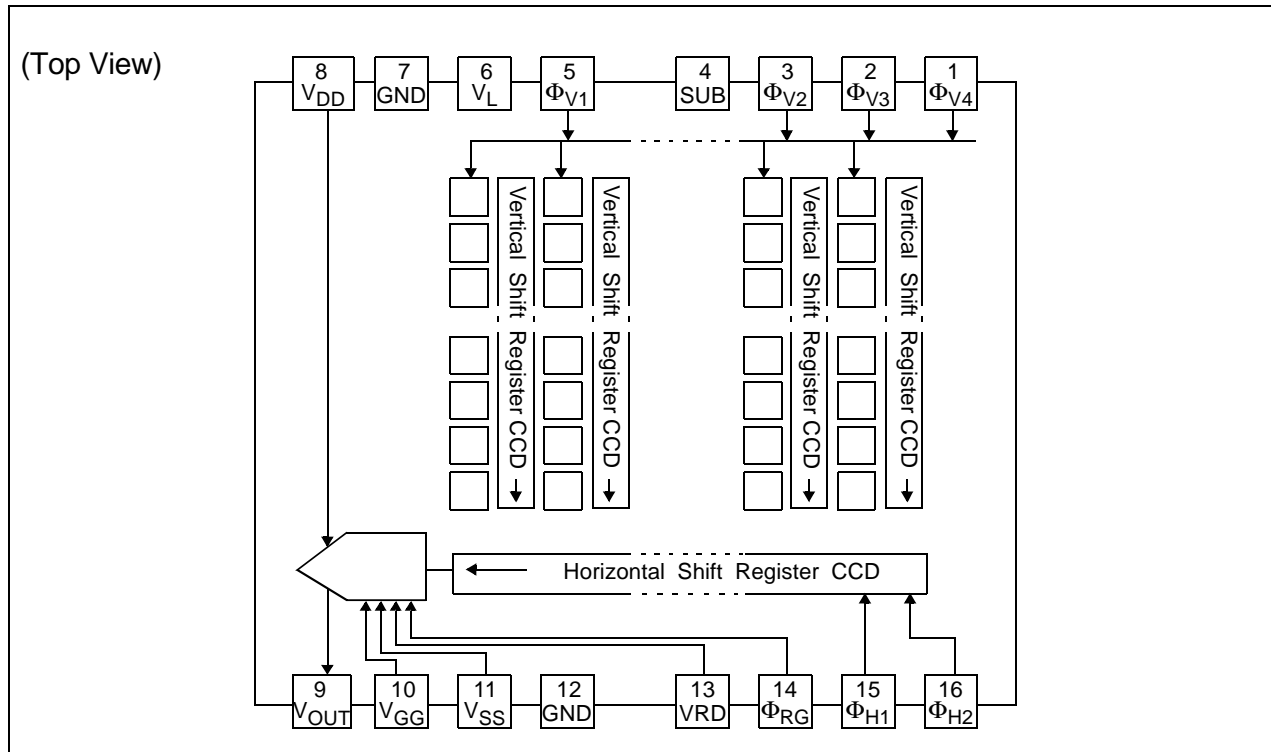


Figure 1. Block Diagram

PIN DESCRIPTION

Table 1. Pin Description

Pin	Symbol	Description	Pin	Symbol	Description
1	Φ_{V4}	Vertical CCD transfer clock 4	9	V_{OUT}	Signal output
2	Φ_{V3}	Vertical CCD transfer clock 3	10	V_{GG}	Output AMP gate voltage
3	Φ_{V2}	Vertical CCD transfer clock 2	11	V_{SS}	Output AMP source voltage
4	SUB	Substrate voltage	12	GND	Ground
5	Φ_{V1}	Vertical CCD transfer clock 1	13	VRD	Reset drain voltage
6	V_L	Protection bias voltage	14	Φ_{RG}	Charge reset clock
7	GND	Ground	15	Φ_{H1}	Horizontal CCD transfer clock 1
8	V_{DD}	Output AMP drain voltage	16	Φ_{H2}	Horizontal CCD transfer clock 2

ABSOLUTE MAXIMUM RATINGS (NOTE)**Table 2. Absolute Maximum Ratings**

Characteristics	Symbols	Min.	Max.	Unit
Substrate voltage	SUB - GND	-0.3	55	V
Supply voltage	V_{DD} , V_{OUT} , $V_{OUT} - GND$	-0.3	17	V
Vertical clock input voltage	Φ_{V1} , Φ_{V2} , Φ_{V3} , $\Phi_{V4} - GND$	-10	20	V
	Φ_{V1} , Φ_{V2} , Φ_{V3} , $\Phi_{V4} - V_L$	-0.3	30	V
Horizontal clock input voltage	Φ_{H1} , $\Phi_{H2} - GND$	-0.3	17	V
Voltage difference between vertical and horizontal clock input pins	Φ_{V1} , Φ_{V2} , Φ_{V3} , Φ_{V4}	-0.3	15	V
	Φ_{H1} , Φ_{H2}	-0.3	17	V
	Φ_{H1} , $\Phi_{H2} - \Phi_{V4}$	-17	17	V
Output clock input voltage	Φ_{RG} , $\Phi_{GG} - GND$	-0.3	17	V
Protection circuit bias voltage	$V_L - SUB$	-65	0.3	V
Operating temperature	T_{OPR}	-10	55	°C
Storage temperature	T_{STG}	-30	80	°C

NOTE: The device can be destroyed, if the applied voltage or temperature is higher than the absolute maximum rating voltage or temperature.

DC CHARACTERISTICS

Table 3. DC Characteristics

Item	Symbol	Min.	Typ.	Max.	Unit	Remark
Output stage drain bias	V_{DD}	14.55	15.0	15.45	V	
Output stage gate voltage	V_{GG}	1.75	2.0	2.25	V	
Output stage source voltage	V_{SS}	Ground through 680Ω			V	±5%
Substrate voltage adjustment range	V_{SUB}	7.0		14.5	V	
Fluctuation voltage range after substrate voltage adjusted	ΔV_{SUB}	-3		3	%	
Reset gate voltage adjustment range	V_{RGL}		0.0	2.0	V	
Protection circuit bias voltage	V_L	V_{VL} voltage of the vertical clock waveform				
Output stage drain current	I_{DD}		2.5		mA	

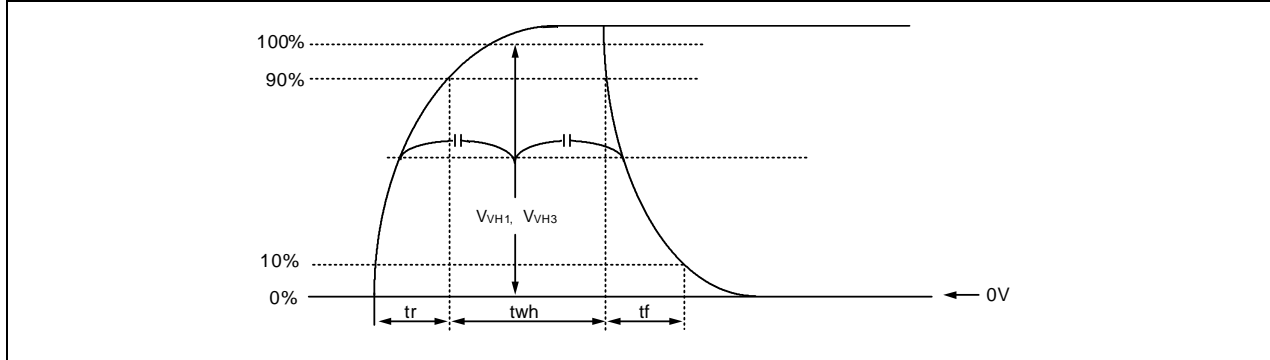
CLOCK VOLTAGE CONDITIONS

Table 4. Clock Voltage Conditions

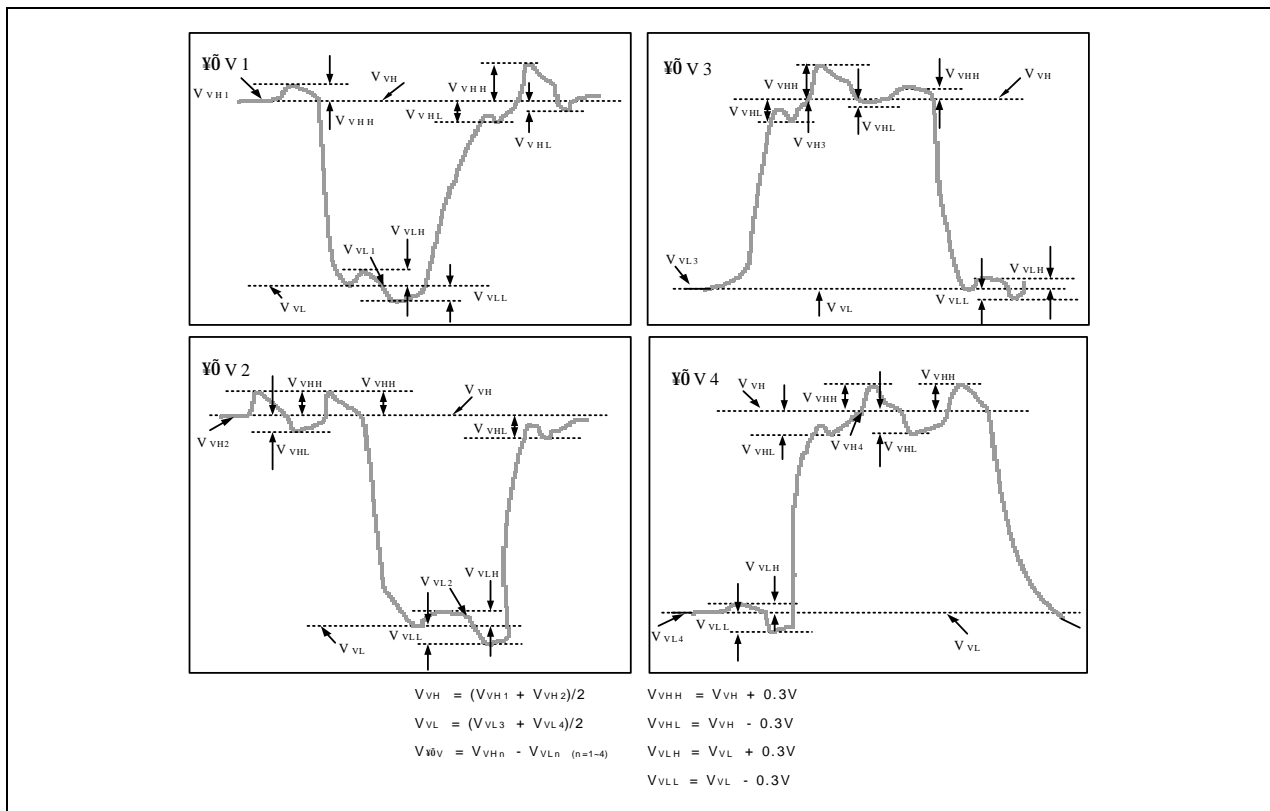
Item	Symbol	Min.	Typ.	Max.	Unit	Remark
Read-out clock voltage	V_{VT}	14.55	15.0	15.45	V	High level
Vertical transfer clock voltage	$V_{VH1} \sim V_{VH4}$	-0.05	0.0	0.05	V	$V_{VH} = (V_{VH1} + V_{VH2})/2$
	$V_{VL1} \sim V_{VL4}$	-9.5	-9.0	-8.5	V	$V_{VL} = (V_{VL3} + V_{VL4})/2$
Horizontal transfer clock voltage	$V_{\Phi H}$	4.75	5.0	5.25	V	High
	V_{HL}	-0.05	0.0	0.05	V	Low
Charge reset clock voltage	$V_{\Phi RG}$	4.75	5.0	5.25	V	High
	$V_{RGLH} - V_{RGLL}$			0.8	V	Low
Substrate clock voltage	$V_{\Phi SUB}$	20.0	23.0	25.0	V	Shutter

DRIVE CLOCK WAVEFORM CONDITIONS

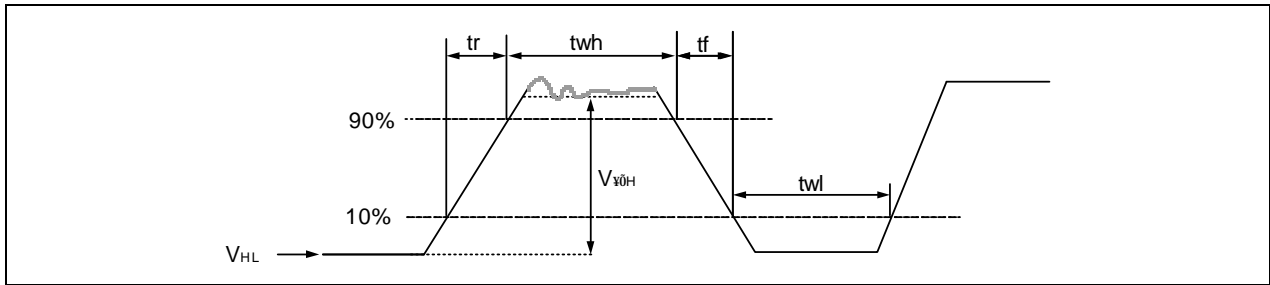
Read Out Clock Waveform



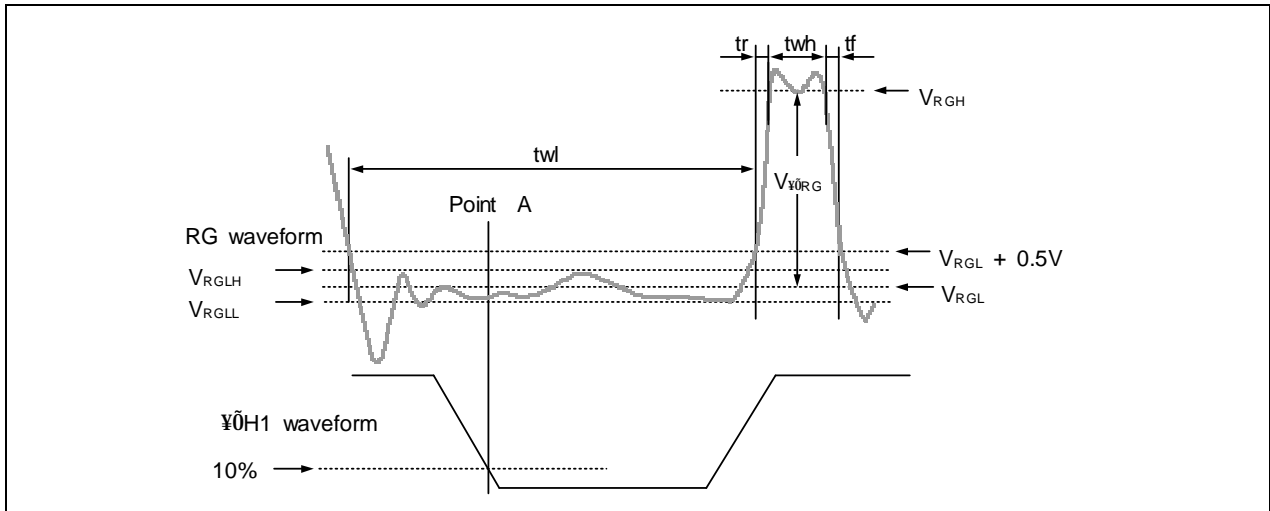
Vertical Transfer Clock Waveform



Horizontal Transfer Clock Waveform Diagram



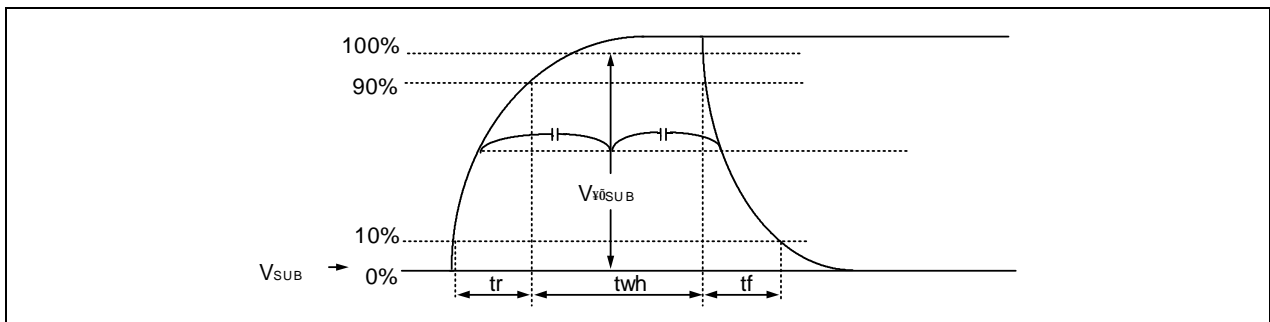
Reset Gate Clock Waveform Diagram



V_{RGLH} is the maximum value and V_{RGL} the minimum value of the coupling waveform in the period from Point A in the diagram about to R_G rise

$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2, V_{FRG} = V_{RGH} - V_{RGL}$$

Substrate Clock Waveform



CLOCK EQUIVALENT CIRCUIT CONSTANT

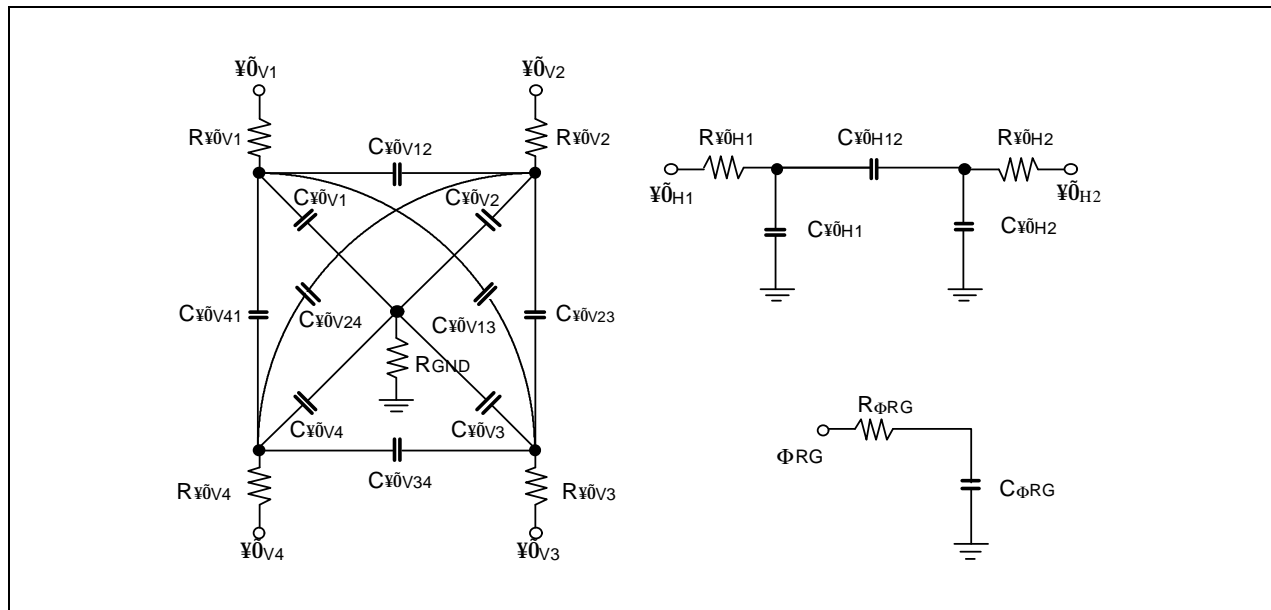
Table 5. Clock Equivalent Circuit Constant

Item	Symbol	twh			twl			tr			tf			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Read-out clock	Φ_{VH}		2.5						0.5			0.5		μs
Vertical clock	Φ_{V1}, Φ_{V2} Φ_{V3}, Φ_{V4}										15		250	ns
Horizontal clock	Φ_{H1}	37	41		38	42			12	15		10	15	ns
	Φ_{H2}	37	41		38	42			12	15		10	15	ns
Reset clock	Φ_{RG}	11	15		75	79			6.5			4.5		ns
Substrate clock	Φ_{SUB}	1.5	2.0						0.5			0.5		μs

EQUIVALENT CIRCUIT PARAMETERS

Table 6. Equivalent Circuit Parameters

Item	Symbol	Typ.	Unit	Remark
Capacitance between vertical transfer clock and GND	$C_{\Phi V1}, C_{\Phi V3}$	1,300	pF	
	$C_{\Phi V2}, C_{\Phi V4}$	1,300	pF	
Capacitance between vertical transfer clocks	$C_{\Phi V12}, C_{\Phi V34}$	600	pF	
	$C_{\Phi V23}, C_{\Phi V41}$	230	pF	
	$C_{\Phi V13}$	120	pF	
	$C_{\Phi V24}$	90	pF	
Capacitance between horizontal transfer clock and GND	$C_{\Phi H1}, C_{\Phi H2}$	38	pF	
Capacitance between horizontal transfer clocks	$C_{\Phi H12}$	38	pF	
Capacitance between reset gate clock and GND	$C_{\Phi RG}$	10	pF	
Capacitance between substrate clock and GND	$C_{\Phi SUB}$	1120	pF	
Vertical transfer clock serial resistor	$R_{\Phi V1} \sim R_{\Phi V4}$	40	Ω	
Vertical transfer clock ground resistor	R_{GND}	15	Ω	
Horizontal transfer clock serial resistor	$R_{\Phi H1}, R_{\Phi H2}$	10	Ω	
Reset gate clock serial resistor	$R_{\Phi RG}$	100	Ω	



OPERATING CHARACTERISTICS

Device Temperature = 25 °C

Table 7. Operating Characteristics

Item	Symbol	Min.	Typ.	Max.	Unit	Remark
Sensitivity	S	60	70		mV/lux	1
Saturation signal	Y_{SAT}	600			mV	2
Smear	SM		0.005	0.012	%	3
Blooming margin	BM	1,000			times	4
Uniformity	U			20	%	5
Dark signal (NOTE)	D			2	mV	6
Dark shading (NOTE)	ΔD			2	mV	7
Image lag	Y_{LAG}			0.5	%	8
Flicker Y	F_Y			2	%	9

NOTE: Test Temperature = 55 °C

TEST CONDITION

1. Use a light source with color temperature of 3,200K hallogen lamp and CM-500S for IR cut filter.
The light source is adjusted in accordance with the average value of Y signals indicated in each item.
2. Through the following tests the substrate voltage should be set to the value while the device condition should be kept within the range of the bias and clock conditions.

TEST METHODS

1. Measure the light intensities (L) when the averaged illuminance output value (Y) is the standard illuminance output value, 150mV (Y_A) and when half of 150mV ($1/2 Y_A$).

$$S = \frac{Y_A - \frac{1}{2}Y_A}{L_{Y_A} - L_{\frac{1}{2}Y_A}}$$

2. Adjust the light intensity to 15 times of the value with which Y is Y_A , then measure the averaged illuminance output value ($Y = Y_{SAT}$).

3. Adjust the light intensity to 500 times of the value with which Y is Y_A , then remove the read-out clock and drain the signal in photosensors by the electronic shutter operation in all the respective horizontal blanking times with the other clocks unchanged. Measure the maximum illuminance output value (Y_{SM}).

$$SM = \frac{Y_{SM}}{Y_A} \times \frac{1}{500} \times \frac{1}{10} \times 100(\%)$$

4. Adjust the light intensity to 1,000 times of the value with which Y is Y_A , then inspect whether there is blooming phenomenon or not.

5. Measure the maximum and minimum illuminance output value (Y_{MAX} , Y_{MIN}) when the light intensity is adjusted to make Y to be Y_A .

$$U = \frac{Y_{MAX} - Y_{MIN}}{Y_A} \times 100(\%)$$

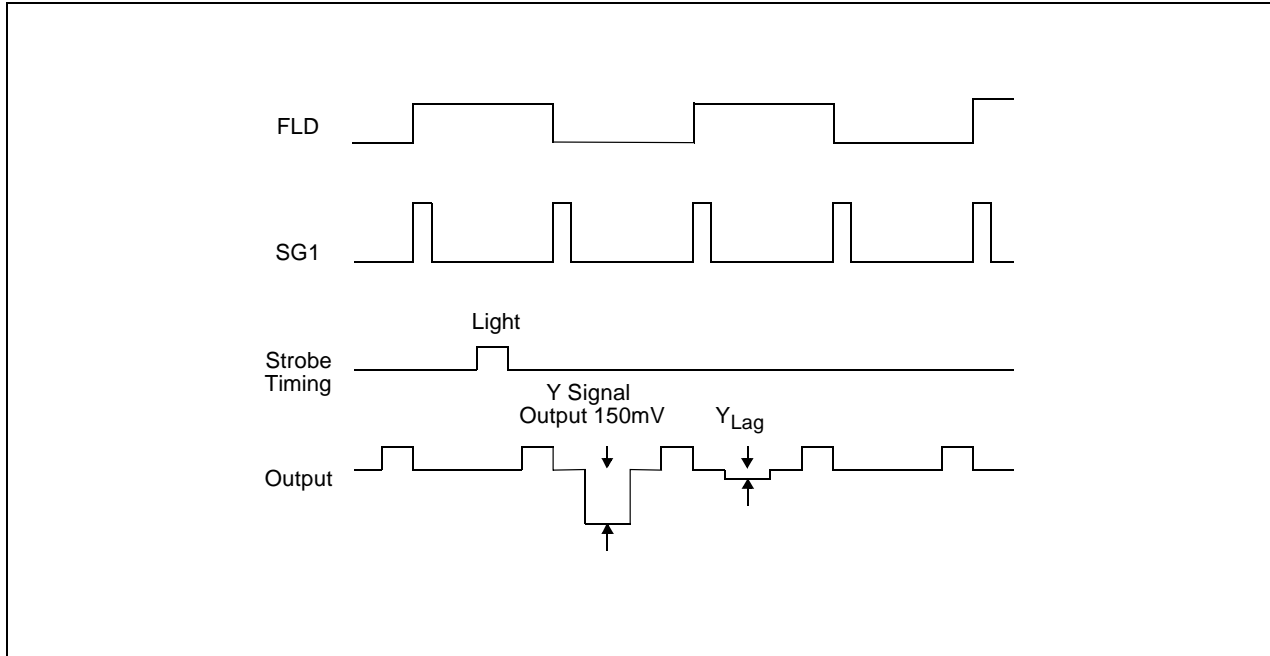
6. Measure Y_D with the horizontal idling time transfer level as reference, when the device ambient temperature is 55 °C and all of the light sources are shielded.

7. Follow test method 6, measure the maximum (D_{MAX}) and minimum illuminance output (D_{MIN}).

$$\Delta D = D_{MAX} - D_{MIN}$$

8. Adjust the light intensity of Y signal output value by strobe light to 150mV (Y_A), calculate by below formula with measuring the image lag signal which is generated by below timing diagram.

$$Y_{LAG} = (Y_{lag}/150) \times 100(\%)$$



9. Adjust the light intensity of Y signal average value to 150mV (Y_A), calculate by below formula with measuring the signal differences (ΔY_f [mV]) between fields.

$$F_Y = (\Delta Y_f / Y_A) \times 100(\%)$$

SPECTRAL RESPONSE CHARACTERISTICS

Excluding Light Source Characteristics

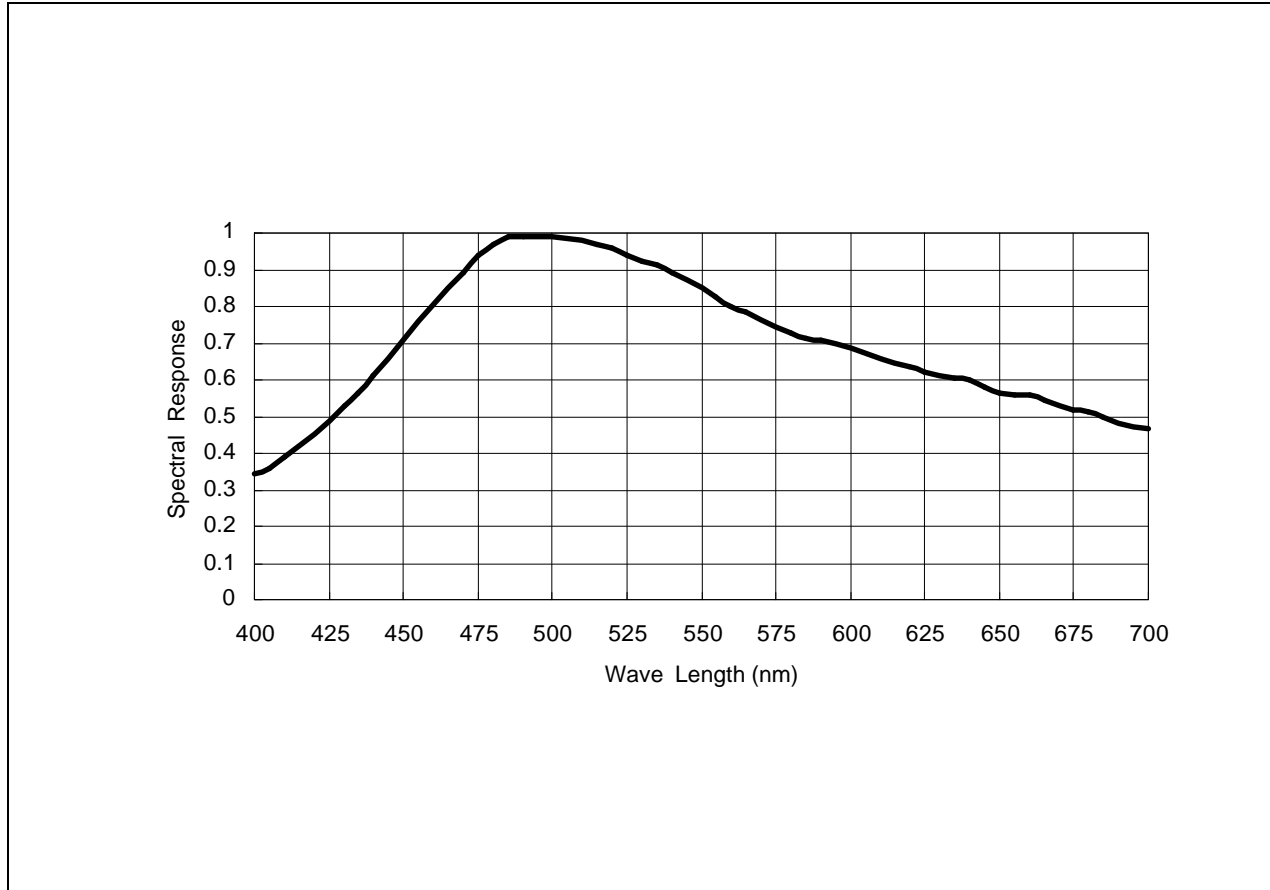


Figure 2. Spectral Response Characteristics

APPLICATION CIRCUITS

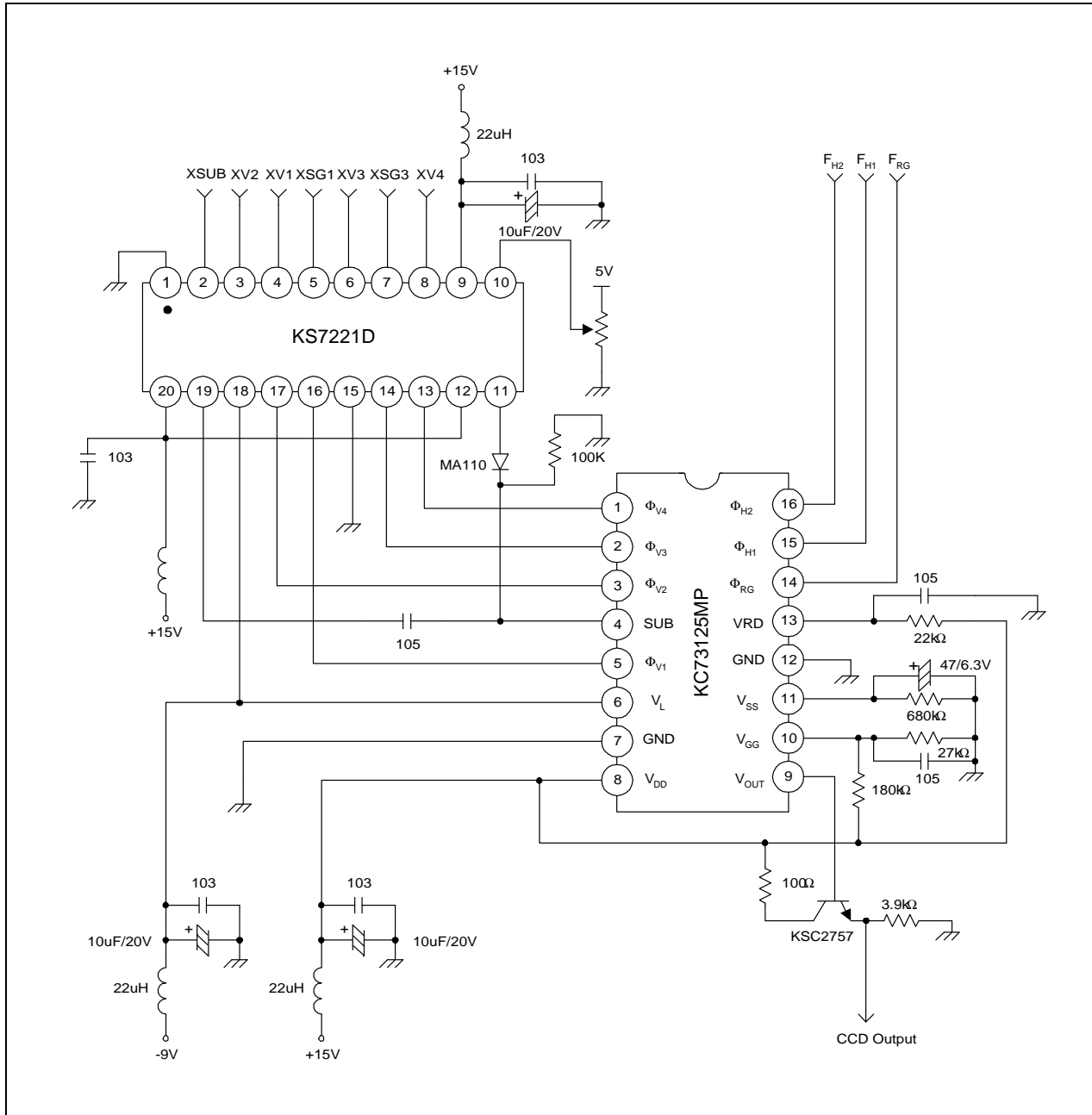


Figure 3. Application Circuits

READ-OUT CLOCK TIMING CHART

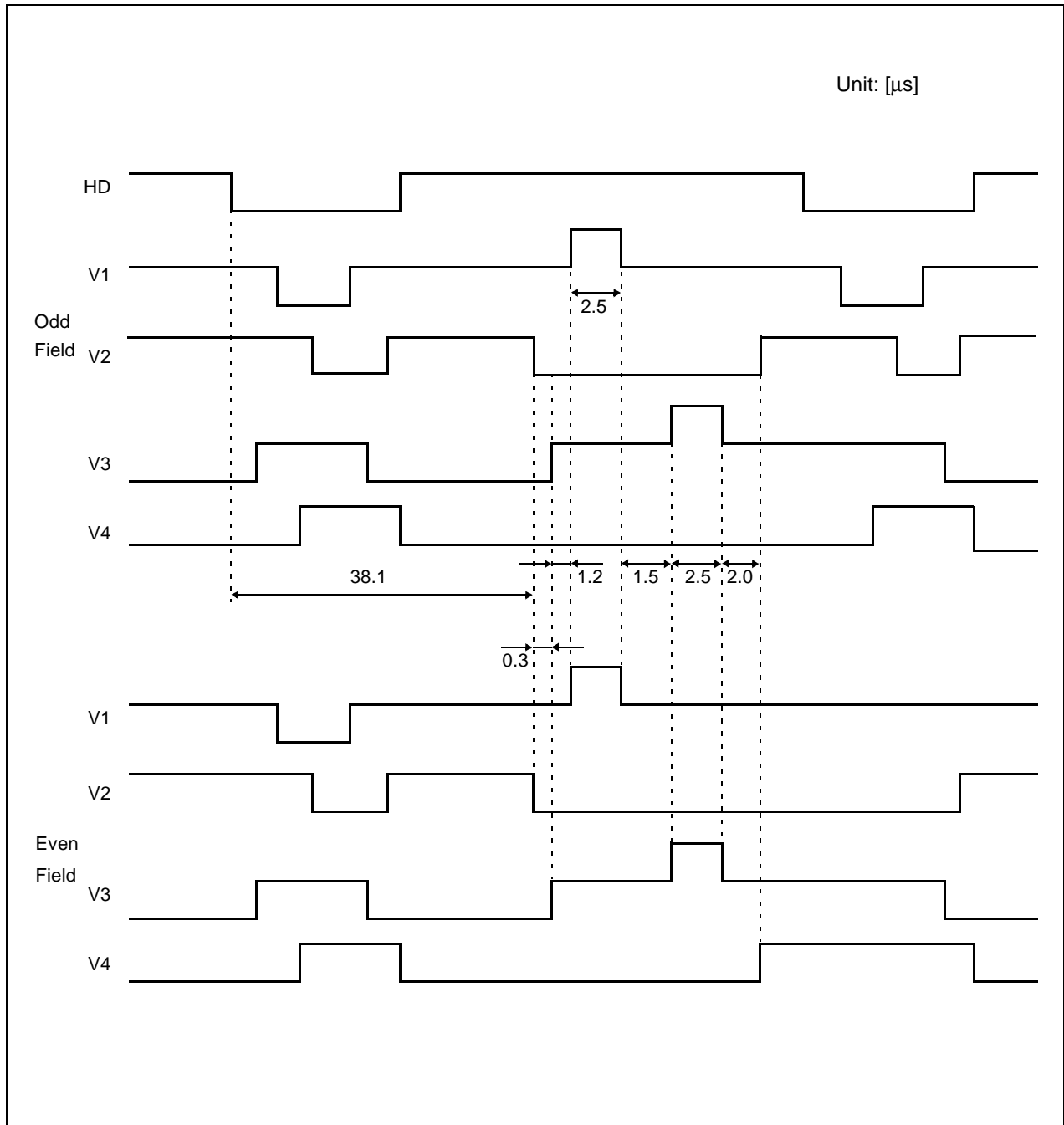


Figure 4. Read-out Clock Timing Chart

CLOCK TIMING CHART (VERTICAL SYNC.)

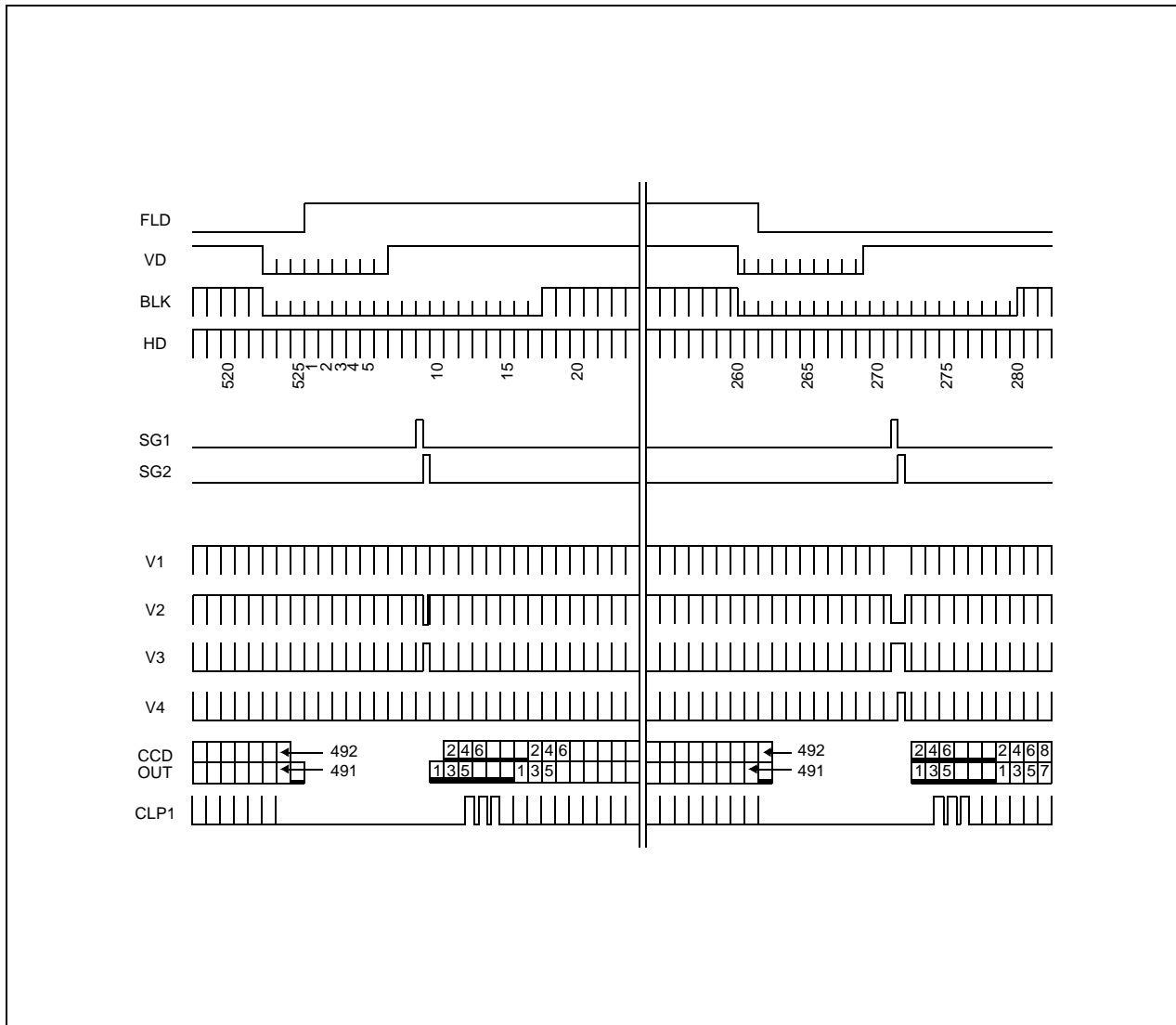


Figure 5. Clock Timing Chart (Vertical Sync.)

CLOCK TIMING CHART (HORIZONTAL SYNC.)

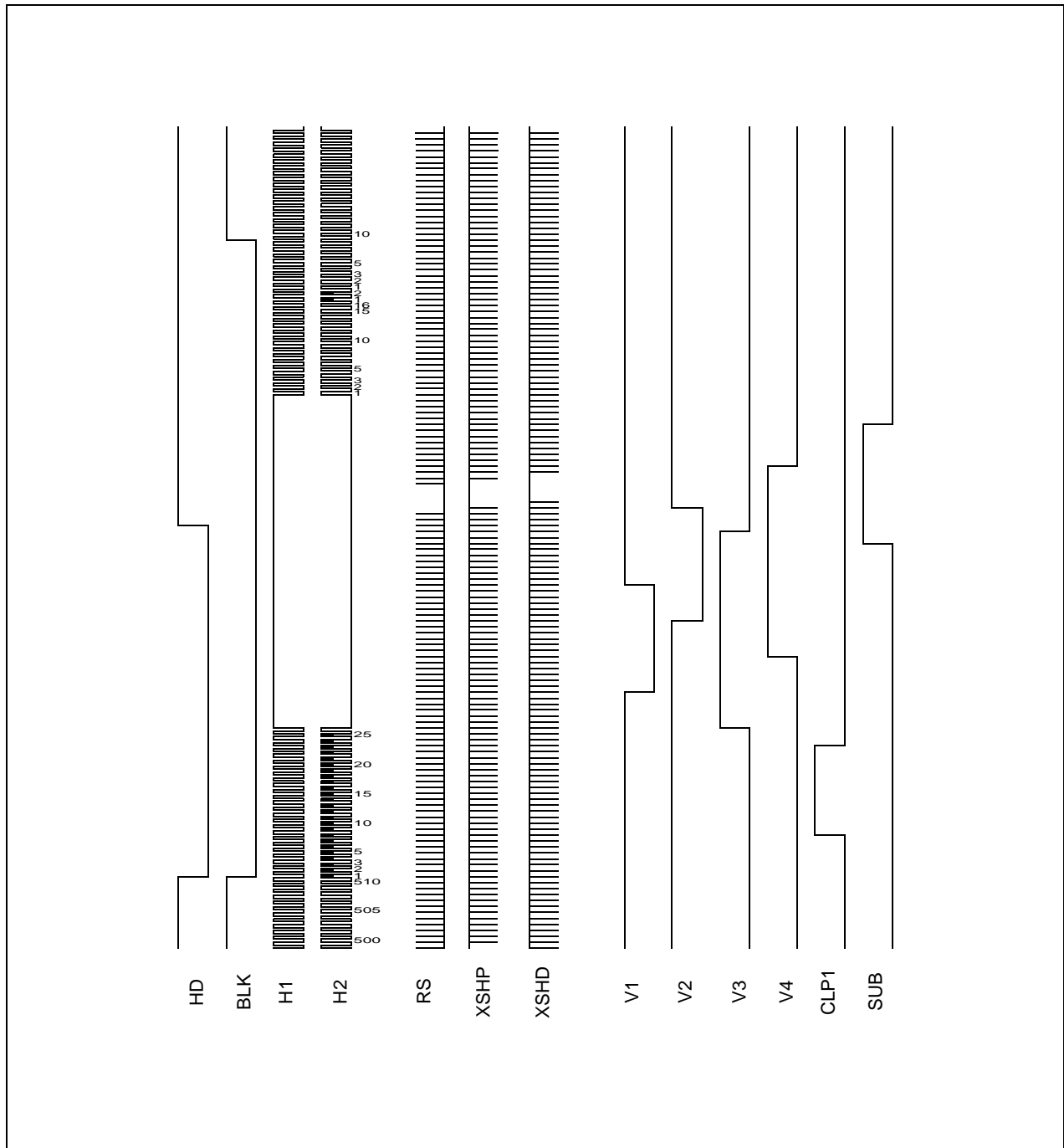


Figure 6. Clock Timing Chart (Horizontal Sync.)

PACKAGE DIMENSIONS

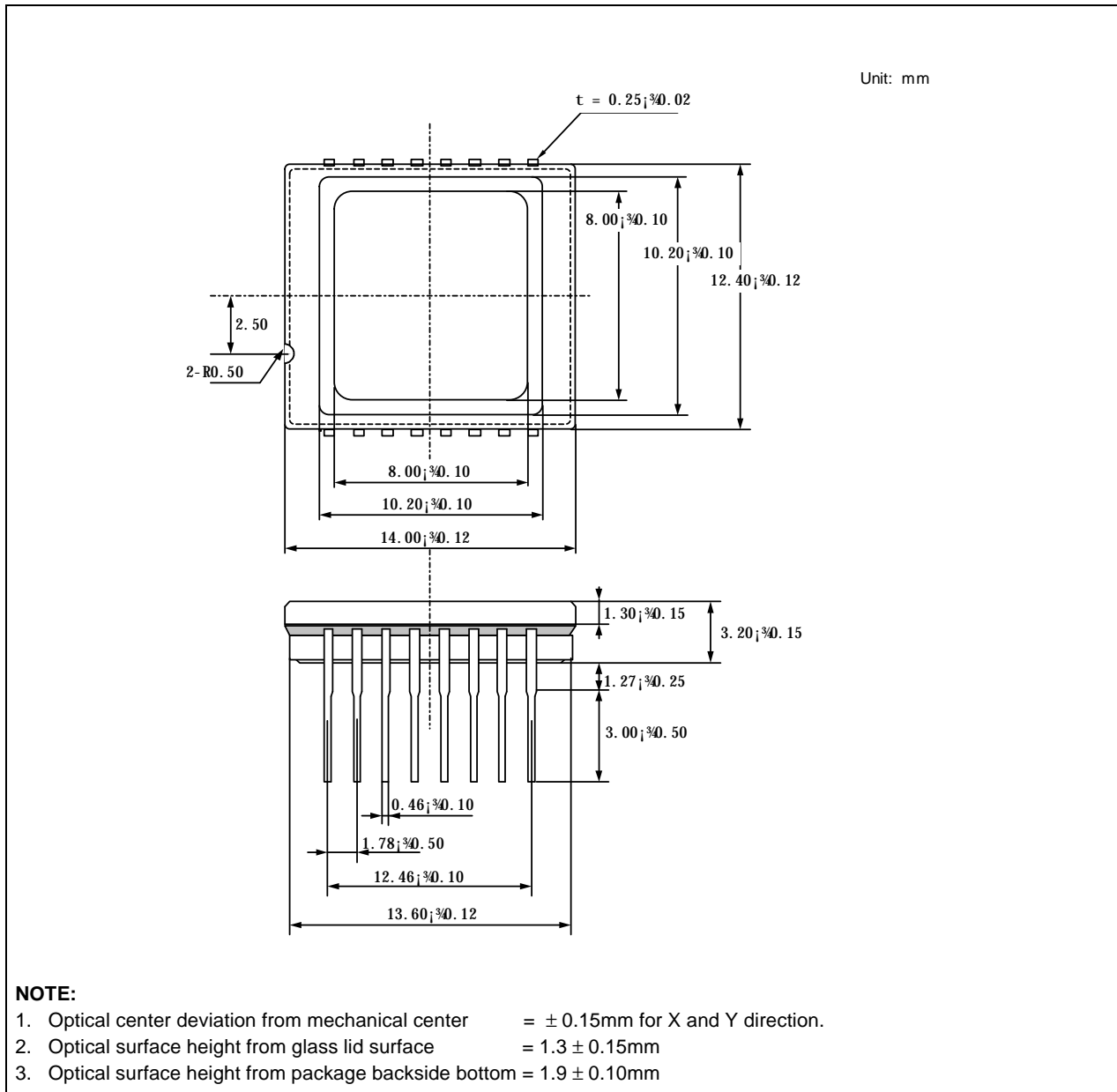


Figure 7. Package Dimensions

HANDLING INSTRUCTIONS

- Static Charge Prevention

CCD image sensors can be easily damaged by static discharge. Before handling, be sure to take the following protective measures.

- Use non chargeable gloves, clothes or material. Also use conductive shoes.
- When handling directly, use an earth band.
- Install a conductive mat on the floor or working table to prevent generation of static electricity.
- Ionized air is recommended for discharging when handling CCD image sensor.
- For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

- Soldering

- Make sure the package temperature does not exceed 80 °C.
- Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a grounded 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- To dismount an imaging device, do not use a solder suction equipment. When using an electronic desoldering tool, use a thermal controller of the zero cross on/off type and connect to ground.

- Dust and Dirt Protection

- Operate in the clean environments (around class 1000 will be appropriate).
- Do not either touch glass plates by hand or have object come in contact with glass surface. Should dirt stick to a glass surface blow it off with an air blow (for dirt stuck through static electricity ionized air is recommended).
- Clean with a cotton bud and ethyl alcohol if the glass surface is grease stained. Be careful not to scratch the glass.
- Keep in case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- When a protective tape is applied before shipping, just before use remove the tape applied electrostatic protection. Do not reuse the tape.

- Do not expose to strong light (sun rays) for long period, color filter are discolored.

- Exposure to high temperature or humidity will affect the characteristics. accordingly avoid storage or usage in such conditions.

- CCD image sensors are precise optical equipment that should not be subject to mechanical shocks.